

<b>Notice of References Cited</b>	Application/Control No. 10/520,262		Applicant(s)/Patent Under Reexamination LEE ET AL.	
	Examiner /James A. Dudek/		Art Unit 2871	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,727,566	04-2004	Fukui et al.	257/437
*	B	US-5,451,695	09-1995	Kawasaki et al.	560/33
*	C	US-5,387,463	02-1995	Nakamura et al.	428/327
*	D	US-5,084,538	01-1992	Suzuki et al.	526/261
*	E	US-5,393,607	02-1995	Kawasaki et al.	428/334
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)			
	U				
	V				
	W				
	X				

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.